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Effect of the let-through energy of overcurrent protective devices on the temperature of conductors during short-circuits

Abstract. The scope of the verification of low-voltage systems covers the earth fault loop impedance measurement. This measurement is usually performed with the use of low-value current meters, which force a current many times lower than the one occurring during a real short-circuit. Therefore, the international standard recommends consideration of the increase of resistance of conductors with the increase of temperature, which may occur during short-circuits. This paper analyses the temperature rise of the conductors during short-circuits, taking into account the let-through energy of protection devices. The analysis has shown that in typical circuits the temperature rise of conductors is not significant.

Streszczenie. W ramach kontroli stanu instalacji niskiego napięcia wykonuje się pomiar impedancji pętli zwarciowej wymuszając prąd znacznie mniejszy niż występujący podczas rzeczywistego zwarcia. Norma dotycząca sprawdzania instalacji niskiego napięcia zaleca, aby w przypadku pomiarów małym prądem, w temperaturze pokojowej, uwzględnić fakt, że podczas zwarcia temperatura i rezystancja przewodów może wzrosnąć, co zaostrza warunek skuteczności ochrony przeciwporażeniowej. W artykule przeanalizowano, w jakim stopniu może wzrosnąć temperatura przewodów podczas zwarć przy uwzględnieniu całki Joule'a wyłączania zabezpieczeń nadprądowych. Z analizy wynika, że wzrost ten jest niewielki. (Wpływ energii przenoszonej przez zabezpieczenia nadprądowe na wzrost temperatury przewodów podczas zwarć).

Keywords: conductors resistance, let-through energy, overcurrent protection, short-circuit. **Słowa kluczowe:** rezystancja przewodów, energia przenoszona, zabezpieczenie nadprądowe, zwarcie.

Introduction

Earth faults both in high- and low-voltage systems may introduce an electric shock hazard. Every safety system, including a system of protection against electric shock, should fulfil at least the (n - 1) condition, i.e. the protection is ensured in case of the first fault (usually an insulation fault). In low-voltage systems, the most popular method of protection in case of a fault (protection against indirect contact) is the automatic disconnection of supply. The lineto-earth short-circuit current should be high enough to initiate tripping of the disconnecting device (circuit-breaker, fuse or residual current device) within the time specified in standard PN-HD 60364-4-41 [1]. This short-circuit current value depends on the value of the loop impedance of the faulty circuit. In order to achieve the effectiveness of protection against electric shock by automatic disconnection of supply, the following condition has to be fulfilled:

$$(1) Z_{\rm s} \le \frac{U_{\rm o}}{I_{\rm a}}$$

where: Z_s – is the earth fault loop impedance (TN-type systems) determining the value of the line-to-earth (earth fault) current; U_o – is the nominal line-to-earth voltage; I_a – is the current causing the automatic operation of the disconnecting device within the specified time [1].

The effectiveness of protection against electric shock is required to be confirmed during the initial and periodic verification of low-voltage electrical installations [2-7]. The scope of this verification is included in standard PN-HD 60364-6 [8]. According to this standard, in TN-type systems (the most common), where possible, the measurement of the earth fault loop impedance is recommended to be carried out.

In practice, the loop impedance is measured with the use of the artificial short-circuit method. This method is utilized by the meters widely accessible in the market. During the measurement, the testing current I_{MC} is forced (Fig. 1), and its value is from milliamps up to several hundred amps – it depends on the type of the meter.

Standard PN-HD 60364-6 [8] informs that consideration of the increase of the resistance of the conductors with the increase of temperature is recommended. For a relatively high value of the temperature of the conductors (in effect it gives a relatively high resistance), the earth fault current can be too low to initiate tripping of the protection device. It is written in this standard (Annex D – informative) that in the case of the measurement at room temperature, with the use of low-current methods (a practically negligible increase of the temperature of the conductors), the measured earth fault loop impedance in TN systems should satisfy the following dependence:

(2)
$$Z_{\rm sm} \le \frac{2}{3} \cdot \frac{U_{\rm o}}{I_{\rm a}}$$

where: $Z_{\rm sm}$ – is the measured earth fault loop impedance.

Such a dependence makes that conditions for effective protection against electric shock are clearly more rigorous (coefficient 2/3). Thus, according to the standard [8], when the measured impedance $Z_{\rm ms}$ exceeds the value described by (2), the more detailed calculation should be performed. In particular, the let-through energy of the protective device installed in the tested circuit should be taken into account.

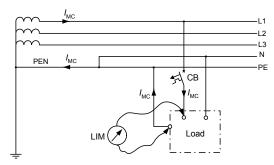


Fig.1. Earth fault loop impedance measurement in a TN-C-S low-voltage system; LIM – loop impedance meter, CB – circuit-breaker, I_{MC} – measuring current

This paper covers the effect of the let-through energy of the protective device on the real increase of the conductors/cables temperature in case of short-circuits (earth faults). Results of the laboratory test of the letthrough energy of selected miniature circuit-breakers and fuses are presented. On the base of this laboratory test and data delivered by the manufacturers of the overcurrent protection devices, the temperatures of conductors, in case of an earth fault, are calculated for an example electrical installation.

Resistance of conductors vs. their temperature

Resistance of conductors R_c and in consequence the loop impedance Z_s (Z_{sm}) given by (1) and (2), strictly depends on the conductors' temperature. The resistance can be calculated according to:

(3)
$$R_{\rm c} = \frac{l}{\gamma_{\rm x} \cdot s}$$

where: l – is the length of the conductor; γ_x – is the conductivity of the conductor in temperature x; s – is the cross-sectional area of the conductor.

The conductivity γ_x in the temperature *x* is calculated in the following way:

(4)
$$\gamma_{\rm x} = \frac{\gamma_{20}}{1 + 0.004(x - 20)}$$

where: γ_{20} – reference conductivity of the conductor (in 20 °C); *x* – given temperature of the conductor.

For commonly used PVC-insulated cables/conductors, the permissible continuous temperature is equal to 70 $^{\circ}$ C. In this temperature, the resistance of conductors is higher by 20% than in 20 $^{\circ}$ C:

(5)
$$R_{\rm c} = \frac{l}{\frac{\gamma_{20}}{1 + 0.004(70 - 20)} \cdot s} = 1.2 \frac{l}{\gamma_{20} \cdot s}$$

From the point of view of the effectiveness of the automatic disconnection of supply, it is important to evaluate the real temperature rise of the conductors during a short-circuit. The temperature rise v can be evaluated according to the following dependence [9]:

(6)
$$\upsilon = (\tau_2 - \tau_1) \frac{I^2 t}{(k \cdot s)^2 \cdot 1}$$

where: τ_1 – is the temperature of the conductor before a short-circuit; τ_2 – is the max permissible temperature of the conductor in the case of a short-circuit; l^2t – is the letthrough energy of the protective device; k – is the max permissible current density in the conductor (within 1 second); s – is the cross-sectional area of the conductor.

For a given type of a cable/conductor, the temperatures τ_1 and τ_2 as well as parameters k and s are known. The Joule integral (let-through energy) l^2t of the protection device can be derived from manufacturers data, but the authors performed also a laboratory test to find out the real values of this parameter.

Results of the laboratory test and calculations

Figure 2 presents the structure of the analyzed example installation. It is assumed that the single-phase loads are supplied via PVC-insulated power cable having aluminium conductors (120 mm²) and PVC-insulated copper conductors (2.5 mm²). The first final circuit is protected by a miniature circuit-breaker (MCB) and the second by a fuse.

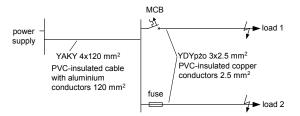


Fig.2. Structure of the analyzed electrical installation; MCB – miniature circuit-breaker

Based on the diagram from Fig. 2, the characteristic parameters of the power cable and final circuits' conductors are as in Table 1.

Table 1. Parameters of the analyzed cable/conductors

Cable/conductor	Temperature °C		Max current density k	
	$ au_1$	$ au_2$	A/mm ²	
YAKY 4x120 mm ²	70	160	76	
YDYpżo 3x2.5 mm ²	70	160	115	

In the investigation of the circuit marked "load 1", the following types of the MCBs have been taken into account: B16, C16 and D20. The MCBs B16 and C16 are the most common types installed in final circuits. Also, the conductor of the cross-sectional area 2.5 mm² (Fig. 2) is very popular in low-voltage final circuits.

First, as an example, the temperature rise of the conductor during a short-circuit has been evaluated on the base of the manufacturers' data for the MCB of B16 type. Such data are presented in Fig. 3.

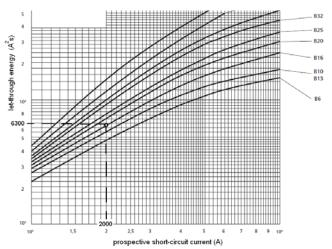


Fig.3. Maximum let-through energy of B-type circuit-breakers declared by the manufacturer [10]; the marked value of the let-through energy (6300 $\mathsf{A}^2s)$ for a circuit-breaker B16 and a prospective short-circuit current 2 kA

For a prospective short-circuit current equal to 2 kA, the value of the B16 MCB let-through energy is equal to 6300 A^2 s (Fig. 3). According to (6) and Tab. 1, it gives the temperature rise of the conductor YDYpżo 3x2.5:

(7)
$$\upsilon = (160 - 70) \frac{6300}{(115 \cdot 2.5)^2 \cdot 1} = 6.9 \text{ k}$$

For the cable YAKY 4x120, the temperature rise is as follows:

(8)
$$\upsilon = (160 - 70) \frac{6300}{(76 \cdot 120)^2 \cdot 1} = 0.007 \text{ K}$$

One can see that the temperature of the conductor YDYpzo 3x2.5 increases only slightly. In case of the cable YAKY 4x120, the increase is completely negligible.

In order to check the real temperature rise, the laboratory test of the MCBs let-through energy has been carried out. Figures 4, 5, and 6 present results of this test for the MCBs B16, C16 and D20 respectively. The process of current breaking and the let-through energy value have been verified for prospective short-circuit currents 1 kA and 2 kA. Results of the temperature rise calculation, for data obtained from the laboratory test, are presented in Table 2.

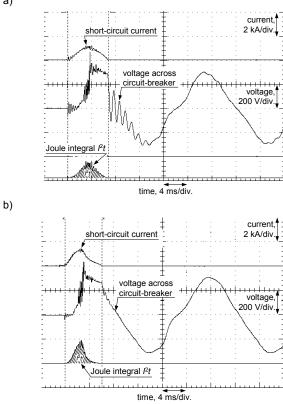


Fig.4. Oscillograms of the real short-circuit current, voltage drop as well as Joule integral (let-through energy) during breaking of current by a circuit-breaker B16, for the value of a prospective short-circuit current: a) 1 kA (3.3 kA²s), b) 2 kA (3.3 kA²s)

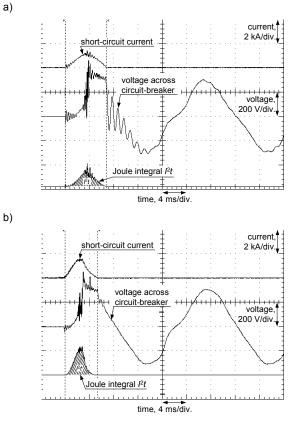


Fig.5. Oscillograms of the real short-circuit current, voltage drop as well as Joule integral (let-through energy) during breaking of current by a circuit-breaker C16, for the value of a prospective short-circuit current: a) 1 kA (3.5 kA²s), b) 2 kA (4.2 kA²s)

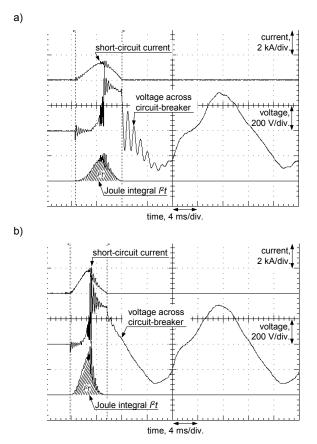


Fig.6. Oscillograms of the real short-circuit current, voltage drop as well as Joule integral (let-through energy) during breaking of current by a circuit-breaker D20, for the value of a prospective short-circuit current: a) 1 kA (5.6 kA²s), b) 2 kA (6.5 kA²s)

Table 2. Temperature rise of the cable/conductors in circuits protected by MCBs

Cable/	Short-	Protection	Let-through	Temp. rise		
conductor	circuit	device	energy I ² t	υ		
	current		kA ² s	K (°C)		
		B16	3.3	3.6		
YDYpżo 3x2.5	1 kA	C16	3.5	3.8		
		D20	5.6	6.1		
		B16	3.3	3.6		
	2 kA	C16	4.2	4.6		
		D20	6.5	7.1		
		B16	3.3	0.004		
YAKY 4x120	1 kA	C16	3.5	0.004		
		D20	5.6	0.006		
		B16	3.3	0.004		
	2 kA	C16	4.2	0.005		
		D20	6.5	0.007		

If one compares the value of the maximum let-through energy for the MCB B16 derived by the manufacturer (Fig. 3: $I^2 t$ = 6300 A²s, for 2 kA) with the let-through energy obtained during the laboratory test (Fig. 4b: $I^2t = 3300 \text{ A}^2\text{s}$, for 2 kA), it is seen that the latter is almost two times lower. It gives only the 3.6 K temperature rise of the conductor YDYpżo 3x2.5 in case of a short-circuit with current 2 kA. The temperature rise of the cable YAKY 4x120 is obviously - negligible (0.004 K). For other MCBs (C16 and D20) the temperature rise of the conductor YDYpżo 3x2.5 is maximum around 7 K and for the cable YAKY 4x120 is close to 0 K.

Even a lower temperature rise is expected in the circuit marked "load 2" (Fig. 2) protected by a fuse. In the investigation, the following general type fuses are taken into account: gG16 and gG20. If the normative maximum values

of the let-through energy I^2t are considered (Tab. 3), the temperature rise of the conductor YDYpżo 3x2.5 protected by a fuse gG16 (I^2t = 1210 A²s) is equal to 1.32 K (Tab. 4). This temperature rise is valid for both analyzed values of the prospective short-circuit currents 1 kA and 2 kA because the let-through energy is approx. constant (from 550 A onwards for gG16 – see Tab. 3). In the case of the cable YAKY 4x120, the temperature practically does not change the value (0.0013 K).

Table 3. Maximum let-through energy $I^2 t$ of the gG fuses (IEC) [11]

Rated current	Prospective short-	l ² t
of the fuse	circuit current	
А	А	A ² s
16	550	1210
20	790	2500

Table 4. Temperature rise of the cable/conductors in circuits protected by gG fuses

Cable/	Protection	Let-through	Short-	Temp. rise	
conductor	device	energy I ² t	circuit	υ	
		A ² s	current	K (°C)	
YDYpżo 3x2.5	gG16	1210 (IEC)	1 kA, 2 kA	1.32	
		1060 (ETI)	1 KA, 2 KA	1.15	
		402 (Lab)	1 kA	0.44	
		453 (Lab)	2 kA	0.49	
	gG20	2500 (IEC)	1 kA, 2 kA	2.72	
		1454 (ETI)	1 KA, 2 KA	1.58	
		807 (Lab)	1 kA	0.88	
		738 (Lab)	2 kA	0.80	
YAKY 4x120	gG16	1210 (IEC)	1 kA, 2 kA	0.0013	
		1060 (ETI)	1 KA, 2 KA	0.0011	
		402 (Lab)	1 kA	0.0004	
		453 (Lab)	2 kA	0.0005	
	gG20	2500 (IEC)	1 kA, 2 kA	0.0027	
		1454 (ETI)	1 KA, 2 KA	0.0016	
		807 (Lab)	1 kA	0.0009	
		738 (Lab)	2 kA	0.0008	
IEC – maximum normative let-through energy according to [11]					
ETI – maximum let-through energy of the ETI products [12]					
Lab – results of the laboratory test					

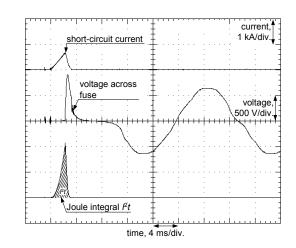


Fig.7. Oscillograms of the real short-circuit current, voltage drop as well as Joule integral (let-through energy) during breaking of current by a fuse gG16, for the value of a prospective short-circuit current 1 kA (402 A^2s)

Calculation of the temperature rise on the base of the selected manufacturer data ("ETI", Tab. 4) enables to say that gG16 fuses have let-through energy not higher than 1060 A^2s , what is clearly lower than the max normative value (1210 A^2s – see. Tab. 3). This value also gives a very small increase in the temperature of the conductor

YDYp2o 3x2.5 (1.15 K). A laboratory test of the fuses shows ("Lab", Tab. 4) that in practice the let-through energy can be significantly lower than the manufacturer declaration (positive effect). Example oscillograms obtained from the testing of a fuse are presented in Fig. 7.

From the above-conducted calculations performed for the example electrical installation, with components having typical parameters, it can be determined that in the case of short-circuits, the temperature rise of the final conductor is relatively low and the temperature rise of the cable in a distribution circuit is practically negligible. This is due to the positive effect of the protection devices in terms of letthrough energy. Thus, during the earth fault loop impedance measurement, the safety margin presented by the expression (2) is too restrictive. Instead of the 2/3 value, this margin is acceptable to be expressed by the value around $0.90\div0.95$.

Conclusions

Analysis of the values of the let-through energy of the protection devices, which are installed in typical low-voltage final circuits shows that the coefficient 2/3 included in the expression (2) gives too restrictive conditions in terms of the effectiveness of automatic disconnection of supply. Fortunately, this expression is only informative (not obligatory), and it is easy to prove that in the case of a short-circuit the temperature rise and resistance rise of the conductors are practically insignificant.

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